Search Notes



Application/Control No.

1066278911549068

Examiner

Veillard, JacquesJACQUES VEILLARD

Applicant(s)/Patent Under Reexamination

CHEFALAS ET AL.BARKER ET

AL. Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
707707	2, 3, 4, 5, 101, 102 with limited keywords (Updated 12/15/2008)1-4, 5, 100-102, 200-202, 205 With Limited Keywords (Updated 12/18/2008	6/17/200812/07/ 2006	J.VJ.V
709	203, 220-225, 236, 246 With limited Keywords (Updated 12/18/2008)	12/07/2006	J.V
715	501.1, 513, 826 With limited Keywords (Updated 12/2008)	12/07/2006	J.V

SEARCH NOTES

Search Notes	Date	Examiner
EIC Database Plus From TC2100	6/12/2008	J.V
Palm Inventors Search	6/17/2008	J.V
East Electronic Database Search Using limited keywords (Updated 12/15/2008)	6/18/2008	J.V
ACM Electronic Databases SearchEIC Plus database search	6/18/200811/21/ 2006	J.VJ.V
Consulted with G. Robinson P.E AU 2168, reviewed the claims	12/06/2006	J.V
Consulted with L.Wassum	12/07/2006	J.V
Consulted with 101 panel, M. Bookbinder confirm that claims 8, and 17-23 are non-statutory	12/07/2006	J.V
East Electronic Database search Using Limited Keywords (Updated 12/18/2008)	12/07/2006	J.V
Inventor search for possible double patenting	12/07/2006	J.V
New EIC Plus Databases Search	12/18/2008	J.V

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			